











ISO7842, ISO7842F

SLLSEJ0F-OCTOBER 2014-REVISED APRIL 2016

ISO7842x High-Performance, 8000-V_{PK} Reinforced Quad-Channel Digital Isolator

Features

- Signaling Rate: Up to 100 Mbps
- Wide Supply Range: 2.25 V to 5.5 V
- 2.25-V to 5.5-V Level Translation
- Wide Temperature Range: -55°C to +125°C
- Low-Power Consumption, Typical 1.7 mA per Channel at 1 Mbps
- Low Propagation Delay: 11 ns Typical (5-V Supplies)
- Industry leading CMTI (Min): ±100 kV/µs
- Robust Electromagnetic Compatibility (EMC)
- System-Level ESD, EFT, and Surge Immunity
- Low Emissions
- Isolation Barrier Life: >40 Years
- Wide Body SOIC-16 Package and Extra-Wide Body SOIC-16 Package Options
- Safety and Regulatory Approvals:
 - 8000-V_{PK} Reinforced Isolation per DIN V VDE V 0884-10 (VDE V 0884-10):2006-12
 - 5.7-kV_{RMS} Isolation for 1 Minute per UL 1577
 - CSA Component Acceptance Notice 5A, IEC 60950-1 and IEC 60601-1 End Equipment Standards
 - CQC Certification per GB4943.1-2011
 - TUV Certification per EN 61010-1 and EN
 - All DW Package Certifications Complete; DWW Package Certifications Complete per UL, VDE, TUV and Planned for CSA and CQC

2 Applications

- **Industrial Automation**
- Motor Control
- **Power Supplies**
- Solar Inverters
- Medical Equipment
- Hybrid Electric Vehicles

3 Description

The ISO7842x device is a high-performance, quadchannel digital isolator with a 8000-V_{PK} isolation device has reinforced isolation certifications according to VDE, CSA, CQC, and TUV. The isolator provides high electromagnetic immunity and low emissions at low-power consumption, while isolating CMOS or LVCMOS digital I/Os. Each isolation channel has a logic input and output buffer separated by a silicon-dioxide (SiO₂) insulation barrier.

This device comes with enable pins that can be used to put the respective outputs in high impedance for multi-master driving applications and to reduce power consumption. The ISO7842 device has two forward and two reverse-direction channels. If the input power or signal is lost, the default output is high for the ISO7842 device and *low* for the ISO7842F device. See the Device Functional Modes section for further details.

Used in conjunction with isolated power supplies, this device helps prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry. innovative Through chip design and layout techniques, electromagnetic compatibility of the ISO7842 device has been significantly enhanced to ease system-level ESD, EFT, surge, and emissions compliance.

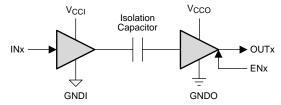
The ISO7842 device is available in 16-pin SOIC wide-body (DW) and extra-wide body (DWW) packages.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ISO7842	DW (16)	10.30 mm × 7.50 mm
ISO7842F	DWW (16)	10.30 mm x 14.0 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Simplified Schematic



V_{CCI} and GNDI are supply and ground connections respectively for the input channels.

V_{CCO} and GNDO are supply and ground connections respectively for the output channels.



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	Changes from Revision E (March 2016) to Revision F	Page
•	Changed the number of years for the isolation barrier life in the Features section	1
•	VDE certification is now complete	1
•	Changed V _{CCO} to V _{CCI} for the minimum value of the input threshold voltage hysteresis parameter in all electrical characteristics tables	8
•	Added V _{CM} to the test condition of the common-mode transient immunity parameter in all electrical characteristics tab	les 8
•	Added the lifetime projection graphs for DW and DWW packages to the Safety Limiting Values section	18
С	Changes from Revision D (December 2015) to Revision E	Page
<u>с</u>		
<u>c</u>	Changed the Safety and Regulatory Approvals list of <i>Features</i>	1
•		1 1
•	Changed the Safety and Regulatory Approvals list of <i>Features</i>	1
•	Changed the Safety and Regulatory Approvals list of <i>Features</i> Added <i>Features</i> "TUV Certification per EN 61010-1 and EN 60950-1" Changed text in the first paragraph of the <i>Description</i> From: "certifications according to VDE, CSA, and CQC". To: "certifications according to VDE, CSA, CQC, and TUV."	1 1 1
•	Changed the Safety and Regulatory Approvals list of <i>Features</i>	1 1 18 19

Changes from Revision C (July 2015) to Revision D Page • Added Features: DW Package Certifications Complete; DWW Certifications Planned 1 • Added text to the Description: and extra-wide body (DWW) packages. 1 • Added package: Extra wide SOIC, DWW (16) to the Device Information table 1

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•	Changed the MIN value of CMTI in <i>Electrical Characteristics</i> —5-V <i>Supply</i> , 5 V table From: 70 To: 100 kV/µs, deleted the TYP value of 100 kV/µs	
	Added the Supply Current - ISO7842DW and ISO7842FDW section to the <i>Electrical Characteristics</i> –5-V <i>Supply</i>	
	Added the Supply Current - ISO7842DWW and ISO7842FDWW section to the <i>Electrical Characteristics—5-V Supply</i>	
•	Changed the MIN value of CMTI in <i>Electrical Characteristics</i> —3.3-V <i>Supply</i> , 5 V table From: 70 To: 100 kV/µs, deleted the TYP value of 100 kV/µs	
•	Added the Supply Current - ISO7842DW and ISO7842FDW section to the <i>Electrical Characteristics</i> —3.3-V Supply	
•	Added the Supply Current - ISO7842DWW and ISO7842FDWW section to the <i>Electrical Characteristics</i> —3.3-V Supply	
•	Changed the MIN value of CMTI in <i>Electrical Characteristics</i> —2.5-V Supply, 5 V table From: 70 To: 100 kV/µs, deleted the TYP value of 100 kV/µs.	
•	Added the Supply Current - ISO7842DW and ISO7842FDW section to the <i>Electrical Characteristics—2.5-V Supply</i>	
•	Added the Supply Current - ISO7842DWW and ISO7842FDWW section to the <i>Electrical Characteristics—2.5-V Supply</i>	
•	Added the 16-DWW Package to Table 2	17
•	Added the DWW package information to Table 3	18
•	Added the DWW package information to Table 5	19
•	Added text to the Application Information section: " isolation voltage per UL 1577."	22
Cł	nanges from Revision B (April 2015) to Revision C	Page
•	Added device ISO7482F to the datasheet	1
•	Changed the Description to include: " default output is 'high' for the ISO7842 device and 'low' for the ISO7842F device	ce 1
•	Changed From: t _{PLH} and t _{PHL} at 5.5V To: t _{PLH} and t _{PHL} at 5.0 V	13
•	Changed Figure 9	15
•	Changed Figure 15 , Added Figure 16	20
•	Added the Device I/O Schematics section	21
Cł	nanges from Revision A (November 2014) to Revision B Changed the document title From: "Quad-Channel Digital Isolator" To: "Quad-Channel 2/2 Digital Isolator"	Page
•	Added Features 2.25 V to 5.5 V Level Translation	
•	Changed Features From: Wide Body SOIC-16 Package To: Wide Body and Extra-Wide Body SOIC-16 Package	1
•	Options	1
•	Changed the Safety and Regulatory Approvals list of Features	
•	VDE certification is now complete	
•	Changed the Simplified Schematic and added Notes 1 and 2	
•	Added the Power Dissipation Characteristics table	
•	Changed Figure 7	
•	Changed Figure 8	14
•	Changed From: V _{CC1} To: V _{CCI} in Figure 9	15
•	Changed Figure 10	15
•	Changed Table 2	17
•	Changed the Test Condition of CTI of the table in Table 2	17
•	Changed the MIN value of CTI From" > 600 V To: 600 V	17
•	Changed Table 3 title From: DIN V VDE 0884-10 (VDE V 0884-10) and UL 1577 Insulation Characteristics To: Insulation Characteristics	18
•	Changed Table 3	18
	Changed the table in Pagulatan Information	40
•	Changed the table in Regulatory Information	19
•	Deleted INPUT-SIDE and OUTPUT-SIDE from columns 1 and 2 of Table 7	

ISO7842, ISO7842F

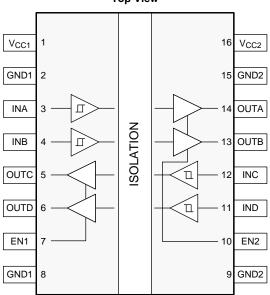


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•	Changed the <i>Typical Application</i> section	22
<u>•</u>	Added text and Figure 19 to the <i>Detailed Design Procedure</i> section	23
CI	nanges from Original (October 2014) to Revision A Pag	је
•	Changed Feature From: All Agencies Approvals Pending To: All Agencies Approvals Planned	1
•	Changed statement in the Description From; "This device is certified to meet reinforced isolation requirements by VDE and CSA." To: "This device is being reviewed for reinforced isolation certification by VDE and CSA."	1
•	Added Note: "This coupler" to the <i>High Voltage Feature Description</i> section	17
•	Changed R _{IO} MIN value From: 10 ⁹ To: 10 ¹¹ in the Table 2 table	17
•	Changed the first row of information in the <i>Regulatory Information</i> table	19



5 Pin Configuration and Functions

DW and DWW Packages 16-Pin SOIC Top View



Pin Functions

PII	N	I/O	DECORPTION	
NAME	NO.	1/0	DESCRIPTION	
EN1	7	I	Output enable 1. Output pins on side 1 are enabled when EN1 is high or open and in high-impedance state when EN1 is low.	
EN2	10	1	Output enable 2. Output pins on side 2 are enabled when EN2 is high or open and in high-impedance state when EN2 is low.	
GND1	2		Ground connection for V _{CC1}	
GNDT	8	_	Ground connection for V _{CC1}	
GND2	9		Ground connection for V _{CC2}	
GND2	15	_	Ground connection for V _{CC2}	
INA	3	I	nput, channel A	
INB	4	I	Input, channel B	
INC	12	I	Input, channel C	
IND	11	I	Input, channel D	
OUTA	14	0	Output, channel A	
OUTB	13	0	Output, channel B	
OUTC	5	0	Output, channel C	
OUTD	6	0	Output, channel D	
V _{CC1}	1	_	Power supply, V _{CC1}	
V _{CC2}	16	_	Power supply, V _{CC2}	

Product Folder Links: ISO7842 ISO7842F



6 Specifications

6.1 Absolute Maximum Ratings

See (1)

			MIN	MAX	UNIT
V_{CC1} , V_{CC2}	Supply volta	e ⁽²⁾	-0.5	6	V
		INx	-0.5	$V_{CCX} + 0.5^{(3)}$	
	Voltage	OUTx	-0.5	$V_{CCX} + 0.5^{(3)}$	V
		ENx	-0.5	$V_{CCX} + 0.5^{(3)}$	
Io	Output curre	ut	-15	15	mA
	Surge immu	ity		12.8	kV
T _{stg}	Storage tem	erature	-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±6000	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	±1500	V

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
V_{CC1} , V_{CC2}	Supply voltage		2.25		5.5	V
		V _{CCO} ⁽¹⁾ = 5 V	-4			
I _{OH}	High-level output current	$V_{CCO}^{(1)} = 3.3 \text{ V}$	-2			mA
		$V_{CCO}^{(1)} = 2.5 \text{ V}$	-1			
		V _{CCO} ⁽¹⁾ = 5 V			4	
I _{OL}	Low-level output current	$V_{CCO}^{(1)} = 3.3 \text{ V}$			2	mA
		$V_{CCO}^{(1)} = 2.5 \text{ V}$			1	
V_{IH}	High-level input voltage		$0.7 \times V_{CCI}^{(1)}$		V _{CCI} ⁽¹⁾	V
V_{IL}	Low-level input voltage		0		$0.3 \times V_{CCI}^{(1)}$	V
DR	Signaling rate		0		100	Mbps
T _J	Junction temperature ⁽²⁾		-55		150	°C
T _A	Ambient temperature		-55	25	125	°C

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All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GND1 or GND2) and are peak voltage values.

Maximum voltage must not exceed 6 V

JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

 $[\]label{eq:VCC} V_{CCI} = Input\text{-side } V_{CC}; \ V_{CCO} = Output\text{-side } V_{CC}.$ To maintain the recommended operating conditions for T_J , see *Thermal Information*.



6.4 Thermal Information

		ISO	ISO7842		
	THERMAL METRIC ⁽¹⁾	DW (SOIC)	DWW (SOIC)	UNIT	
	THERMAL METRIC	16 Pins	16 Pins		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	78.9	78.9	°C/W	
R _{θJC(top)}	Junction-to-case(top) thermal resistance	41.6	41.1	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	43.6	49.5	°C/W	
ΨЈТ	Junction-to-top characterization parameter	15.5	15.2	°C/W	
ΨЈВ	Junction-to-board characterization parameter	43.1	48.8	°C/W	
R ₀ JC(bottom)	Junction-to-case(bottom) thermal resistance	N/A	N/A	°C/W	

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.5 Power Dissipation Characteristics

			VALUE	UNIT
P_D	Maximum power dissipation by ISO78420x		200	
P _{D1}	Maximum power dissipation by side-1 of ISO78420x	$V_{CC1} = V_{CC2} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C},$ $C_L = 15 \text{ pF, input a 50 MHz 50\% duty cycle}$	100	mW
P _{D2}	Maximum power dissipation by side-2 of ISO78420x	square wave	100	

Product Folder Links: ISO7842 ISO7842F



6.6 Electrical Characteristics-5-V Supply

 $V_{CC1} = V_{CC2} = 5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

001	002	. 0	,			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	I _{OH} = -4 mA; see Figure 7	$V_{CCO}^{(1)} - 0.4$	$V_{CCO}^{(1)} - 0.2$		V
V _{OL}	Low-level output voltage	I _{OL} = 4 mA; see Figure 7		0.2	0.4	V
V _{I(HYS)}	Input threshold voltage hysteresis		0.1 x V _{CCI} ⁽¹⁾			V
I _{IH}	High-level input current	V _{IH} = V _{CCI} ⁽¹⁾ at INx or ENx			10	
I _{IL}	Low-level input current	V _{IL} = 0 V at INx or ENx	-10			μA
CMTI	Common-mode transient immunity	$V_I = V_{CCI}^{(1)}$ or 0 V, $V_{CM} = 1500$ V; see Figure 10	100			kV/µs

⁽¹⁾ $V_{CCI} = Input\text{-side } V_{CC}$; $V_{CCO} = Output\text{-side } V_{CC}$.

6.7 Supply Current Characteristics-5-V Supply

 $V_{CC1} = V_{CC2} = 5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TE	ST CONDITIONS	SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO7842DW AN	D ISO7842FDW						
	Disable	EN1 = EN2 = 0V, V_1 = 0 V (ISO7842F), V_1 = $V_{CCI}^{(1)}$ (ISO7842)	I _{CC1} , I _{CC2}		1	1.5	mA
	Disable	EN1 = EN2 = 0 V, $V_I = V_{CCI}^{(1)}$ (ISO7842F), $V_I = 0$ V (ISO7842)	I _{CC1} , I _{CC2}		3.4	4.8	mA
Supply current	DO simus!	V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		2	2.7	mA
опрыу синсти	DC signal	$V_I = V_{CCI}^{(1)}$ (ISO7842F), $V_I = 0$ V (ISO7842)	I _{CC1} , I _{CC2}		4.4	6.1	mA
	All channels switching with	1 Mbps	I _{CC1} , I _{CC2}		3.3	4.6	mA
	square wave clock input;	10 Mbps	I _{CC1} , I _{CC2}		4.2	5.6	mA
	$C_L = 15 \text{ pF}$	100 Mbps	I _{CC1} , I _{CC2}		13.7	16.6	mA
ISO7842DWW A	ND ISO7842FDWW						
	Disable	EN1 = EN2 = 0V, V_1 = 0 V (ISO7842F), $V_1 = V_{CC1}^{(1)}$ (ISO7842)	I _{CC1} , I _{CC2}		1	1.5	mA
	Disable	EN1 = EN2 = 0 V, $V_I = V_{CCI}^{(1)}$ (ISO7842F), $V_I = 0$ V (ISO7842)	I _{CC1} , I _{CC2}		3.4	4.8	mA
Supply current	DO simus!	V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		2	2.8	mA
очрру сипен	DC signal	$V_I = V_{CCI}^{(1)}$ (ISO7842F), $V_I = 0$ V (ISO7842)	I _{CC1} , I _{CC2}		4.4	6.3	mA
	All channels switching with	1 Mbps	I _{CC1} , I _{CC2}		3.4	4.7	mA
	square wave clock input;	10 Mbps	I _{CC1} , I _{CC2}		4.3	5.9	mA
	$C_L = 15 \text{ pF}$	100 Mbps	I _{CC1} , I _{CC2}		14	17.3	mA

⁽¹⁾ $V_{CCI} = Input\text{-side } V_{CC}$; $V_{CCO} = Output\text{-side } V_{CC}$.



6.8 Electrical Characteristics—3.3-V Supply

 $V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

- 001	002	. 0	,			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	I _{OH} = -2 mA; see Figure 7	$V_{CCO}^{(1)} - 0.4$	$V_{\rm CCO}^{(1)} - 0.2$		V
V _{OL}	Low-level output voltage	I _{OL} = 2 mA; see Figure 7		0.2	0.4	V
V _{I(HYS)}	Input threshold voltage hysteresis		0.1 × V _{CCI} ⁽¹⁾			V
I _{IH}	High-level input current	V _{IH} = V _{CCI} ⁽¹⁾ at INx or ENx			10	μΑ
I _{IL}	Low-level input current	V _{IL} = 0 V at INx or ENx	-10			μA
CMTI	Common-mode transient immunity	$V_1 = V_{CCI}^{(1)}$ or 0 V, $V_{CM} = 1500$ V; see Figure 10	100			kV/μs

⁽¹⁾ $V_{CCI} = Input\text{-side } V_{CC}$; $V_{CCO} = Output\text{-side } V_{CC}$.

6.9 Supply Current Characteristics—3.3-V Supply

 $V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TE	EST CONDITIONS	SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO7842DW AN	ID ISO7842FDW					•	
	Disable	EN1 = EN2 = 0 V, V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		1	1.5	mA
	Disable	EN1 = EN2 = 0 V, $V_1 = V_{CC1}^{(1)}$ (ISO7842F), $V_1 = 0$ V (ISO7842)	I _{CC1} , I _{CC2}		3.4	4.8	mA
Supply current	DO simul	V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		2	2.7	mA
Cupply current	DC signal	V _I = V _{CCI} ⁽¹⁾ (ISO7842F), V _I = 0 V (ISO7842)	I _{CC1} , I _{CC2}		4.4	6.1	mA
	All channels switching with	1 Mbps	I _{CC1} , I _{CC2}		3.3	4.5	mA
	square wave clock input;	10 Mbps	I _{CC1} , I _{CC2}		4	5.2	mA
	$C_L = 15 pF$	100 Mbps	I _{CC1} , I _{CC2}		10.8	12.9	mA
ISO7842DWW a	and ISO7842FDWW					•	
	Disable	EN1 = EN2 = 0 V, V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		1	1.5	mA
	Disable	EN1 = EN2 = 0 V, V _I = V _{CCI} ⁽¹⁾ (ISO7842F), V _I = 0 V (ISO7842)	I _{CC1} , I _{CC2}		3.4	4.8	mA
Supply current	DC signal	V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		2	2.8	mA
Cappiy Current	DC signal	V _I = V _{CCI} ⁽¹⁾ (ISO7842F), V _I = 0 V (ISO7842)	I _{CC1} , I _{CC2}		4.4	6.3	mA
	All channels switching with	1 Mbps	I _{CC1} , I _{CC2}		3.4	4.7	mA
	square wave clock input;	10 Mbps	I _{CC1} , I _{CC2}		4.1	5.5	mA
	$C_L = 15 pF$	100 Mbps	I _{CC1} , I _{CC2}		11	13.6	mA

⁽¹⁾ $V_{CCI} = Input\text{-side } V_{CC}$; $V_{CCO} = Output\text{-side } V_{CC}$.



6.10 Electrical Characteristics—2.5-V Supply

 $V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

001	002	, ,	,			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	I _{OH} = -1 mA; see Figure 7	$V_{CCO}^{(1)} - 0.4$	$V_{CCO}^{(1)} - 0.2$		V
V _{OL}	Low-level output voltage	I _{OL} = 1 mA; see Figure 7		0.2	0.4	V
V _{I(HYS)}	Input threshold voltage hysteresis		0.1 × V _{CCI} ⁽¹⁾			V
I _{IH}	High-level input current	V _{IH} = V _{CCI} ⁽¹⁾ at INx or ENx			10	μA
I _{IL}	Low-level input current	V _{IL} = 0 V at INx or ENx	-10			μΑ
CMTI	Common-mode transient immunity	$V_{I} = V_{CCI}^{(1)}$ or 0 V, $V_{CM} = 1500$ V; see Figure 10	100			kV/μs

⁽¹⁾ $V_{CCI} = Input\text{-side } V_{CC}$; $V_{CCO} = Output\text{-side } V_{CC}$.

6.11 Supply Current Characteristics—2.5-V Supply

 $V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TE	ST CONDITIONS	SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO7842DW AN	ID ISO7842FDW						
	Disable	EN1 = EN2 = 0 V, V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		1	1.5	mA
	Disable	EN1 = EN2 = 0 V, $V_I = V_{CCI}^{(1)}$ (ISO7842F), $V_I = 0$ V (ISO7842)	I _{CC1} , I _{CC2}		3.4	4.8	mA
Supply current	DO simul	V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		2	2.7	mA
Cupply current	DC signal	V _I = V _{CCI} ⁽¹⁾ (ISO7842F), V _I = 0 V (ISO7842)	I _{CC1} , I _{CC2}		4.4	6.1	mA
	All channels switching with	1 Mbps	I _{CC1} , I _{CC2}		3.2	4.5	mA
	square wave clock input;	10 Mbps	I _{CC1} , I _{CC2}		3.7	5.1	mA
	$C_L = 15 pF$	100 Mbps	I _{CC1} , I _{CC2}		8.9	10.8	mA
ISO7842DWW	AND ISO7842FDWW						
	Disable	EN1 = EN2 = 0 V, V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		1	1.5	mA
	Disable	EN1 = EN2 = 0 V, V _I = V _{CCI} ⁽¹⁾ (ISO7842F), V _I = 0 V (ISO7842)	I _{CC1} , I _{CC2}		3.4	4.8	mA
Supply current	DC signal	V _I = 0 V (ISO7842F), V _I = V _{CCI} ⁽¹⁾ (ISO7842)	I _{CC1} , I _{CC2}		2	2.8	mA
опрыу синен	DC signal	V _I = V _{CCI} ⁽¹⁾ (ISO7842F), V _I = 0 V (ISO7842)	I _{CC1} , I _{CC2}		4.4	6.3	mA
	All channels switching with	1 Mbps	I _{CC1} , I _{CC2}		3.3	4.6	mA
	square wave clock input;	10 Mbps	I _{CC1} , I _{CC2}		3.8	5.3	mA
	$C_L = 15 pF$	100 Mbps	I _{CC1} , I _{CC2}		9	11.5	mA

⁽¹⁾ $V_{CCI} = Input\text{-side } V_{CC}$; $V_{CCO} = Output\text{-side } V_{CC}$.



6.12 Switching Characteristics—5-V Supply

 $V_{CC1} = V_{CC2} = 5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	Co. 5:	6	11	16	ns
PWD	Pulse width distortion ⁽¹⁾ t _{PHL} - t _{PLH}	See Figure 7		0.55	4.1	ns
t _{sk(o)}	Channel-to-channel output skew time (2)	Same-direction channels			2.5	ns
t _{sk(pp)}	Part-to-part skew time (3)				4.5	ns
t _r	Output signal rise time	Con Figure 7		1.7	3.9	ns
t _f	Output signal fall time	See Figure 7		1.9	3.9	ns
t _{PHZ}	Disable propagation delay, high-to-high impedance output			12	20	ns
t _{PLZ}	Disable propagation delay, low-to-high impedance output			12	20	ns
	Enable propagation delay, high impedance-to-high output for ISO7842	See Figure 0		10	20	ns
t _{PZH}	Enable propagation delay, high impedance-to-high output for ISO7842F	See Figure 8		2	2.5	μs
	Enable propagation delay, high impedance-to-low output for ISO7842			2	2.5	μs
t _{PZL}	Enable propagation delay, high impedance-to-low output for ISO7842F			10	20	ns
t _{fs}	Default output delay time from input power loss	Measured from the time V _{CC} goes below 1.7 V. See Figure 9		0.2	9	μs
t _{ie}	Time interval error	2 ¹⁶ – 1 PRBS data at 100 Mbps		0.90		ns

⁽¹⁾ Also known as pulse skew.

6.13 Switching Characteristics—3.3-V Supply

V_{CC1} = V_{CC2} = 3.3 V ±10% (over recommended operating conditions unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH},t_{PHL}	Propagation delay time	Con Figure 7	6	10.8	16	ns
PWD	Pulse width distortion ⁽¹⁾ t _{PHL} - t _{PLH}	See Figure 7		0.7	4.2	ns
t _{sk(o)}	Channel-to-channel output skew time (2)	Same-direction channels			2.2	ns
t _{sk(pp)}	Part-to-part skew time (3)				4.5	ns
t _r	Output signal rise time	Con Figure 7		0.8	3	ns
t _f	Output signal fall time	See Figure 7		0.8	3	ns
t _{PHZ}	Disable propagation delay, high-to-high impedance output			17	32	ns
t _{PLZ}	Disable propagation delay, low-to-high impedance output			17	32	ns
	Enable propagation delay, high impedance-to-high output for ISO7842	Can Figure 0		17	32	ns
t _{PZH}	Enable propagation delay, high impedance-to-high output for ISO7842F	See Figure 8		2	2.5	μs
	Enable propagation delay, high impedance-to-low output for ISO7842			2	2.5	μs
t _{PZL}	Enable propagation delay, high impedance-to-low output for ISO7842F			17	32	ns
t _{fs}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.7 V. See Figure 9		0.2	9	μs
t _{ie}	Time interval error	2 ¹⁶ – 1 PRBS data at 100 Mbps		0.91		ns

⁽¹⁾ Also known as Pulse Skew.

Product Folder Links: ISO7842 ISO7842F

⁽²⁾ t_{sk(o)} is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

⁽³⁾ t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

t_{sk(o)} is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

⁽³⁾ t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.



6.14 Switching Characteristics—2.5-V Supply

 $V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	One Figure 7	7.5	11.7	17.5	ns
PWD	Pulse width distortion ⁽¹⁾ t _{PHL} - t _{PLH}	See Figure 7		0.66	4.2	ns
t _{sk(o)}	Channel-to-channel output skew time (2)	Same-direction Channels			2.2	ns
t _{sk(pp)}	Part-to-part skew time (3)				4.5	ns
t _r	Output signal rise time	See Figure 7		1	3.5	ns
t _f	Output signal fall time	See Figure 7		1.2	3.5	ns
t _{PHZ}	Disable propagation delay, high-to-high impedance output			22	45	ns
t _{PLZ}	Disable propagation delay, low-to-high impedance output			22	45	ns
	Enable propagation delay, high impedance-to-high output for ISO7842	Can Firmer 0		18	45	ns
t _{PZH}	Enable propagation delay, high impedance-to-high output for ISO7842F	See Figure 8		2	2.5	μs
	Enable propagation delay, high impedance-to-low output for ISO7842			2	2.5	μs
t _{PZL}	Enable propagation delay, high impedance-to-low output for ISO7842F			18	45	ns
t _{fs}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.7 V. See Figure 9		0.2	9	μs
t _{ie}	Time interval error	2 ¹⁶ – 1 PRBS data at 100 Mbps		0.91		ns

⁽¹⁾ Also known as pulse skew.

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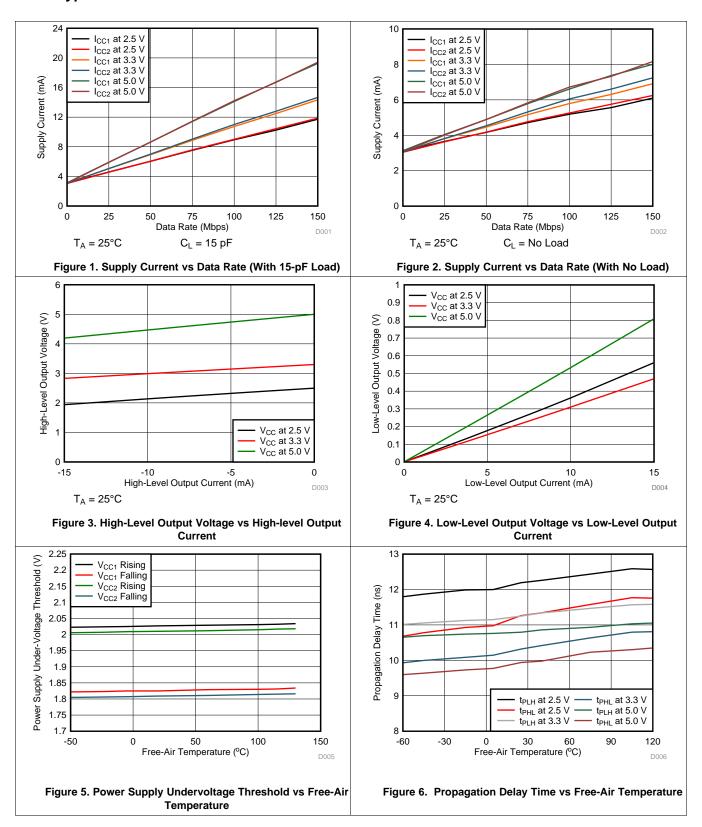
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⁽z) t_{sk(o)} is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

⁽³⁾ $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

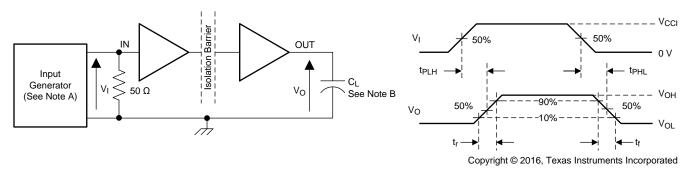


6.15 Typical Characteristics



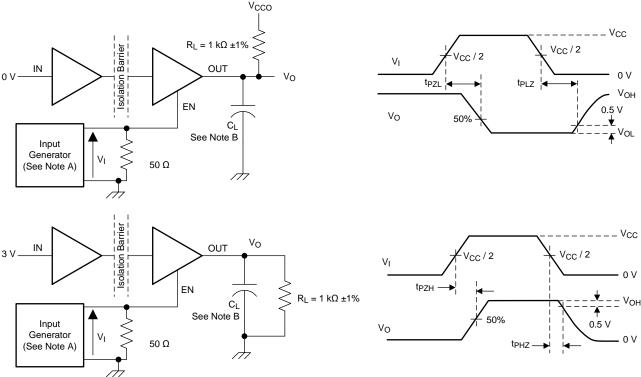
TEXAS INSTRUMENTS

7 Parameter Measurement Information



- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns, $Z_O =$ 50 Ω . At the input, 50 Ω resistor is required to terminate Input Generator signal. It is not needed in actual application.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 7. Switching Characteristics Test Circuit and Voltage Waveforms



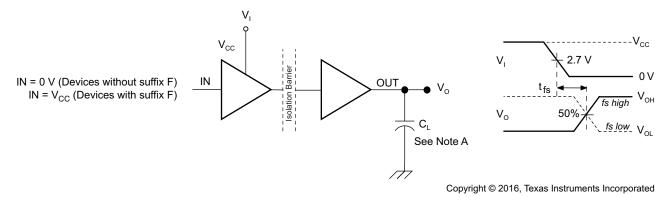
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- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 10 kHz, 50% duty cycle, $t_f \leq$ 3 ns, $t_f \leq$ 3 ns, $Z_O =$ 50 Ω .
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 8. Enable/Disable Propagation Delay Time Test Circuit and Waveform

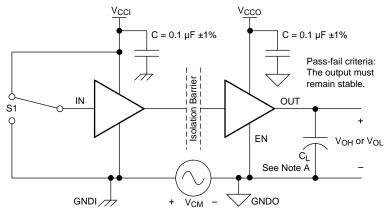


Parameter Measurement Information (continued)



A. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 9. Default Output Delay Time Test Circuit and Voltage Waveforms



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A. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 10. Common-Mode Transient Immunity Test Circuit

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8 Detailed Description

8.1 Overview

The ISO7842 device uses an ON-OFF Keying (OOK) modulation scheme to transmit the digital data across a silicon-dioxide based isolation barrier. The transmitter sends a high-frequency carrier across the barrier to represent one digital state and sends no signal to represent the other digital state. The receiver demodulates the signal after advanced signal conditioning and produces the output through a buffer stage. If the EN pin is low then the output goes to high impedance. The ISO7842 device also incorporates advanced circuit techniques to maximize the CMTI performance and minimize the radiated emissions because of the high-frequency carrier and IO buffer switching. The conceptual block diagram of a digital capacitive isolator, Figure 11, shows a functional block diagram of a typical channel.

8.2 Functional Block Diagram

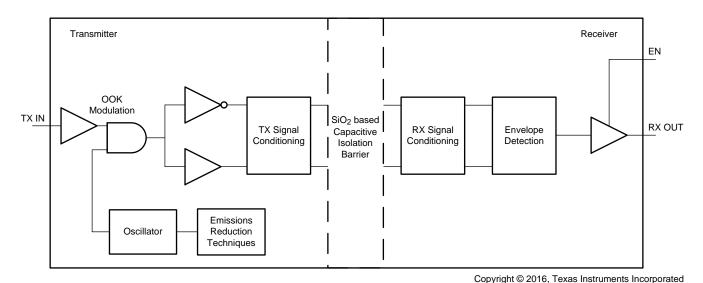


Figure 11. Conceptual Block Diagram of a Digital Capacitive Isolator

Figure 12 shows a conceptual detail of how the ON-OFF keying scheme works.

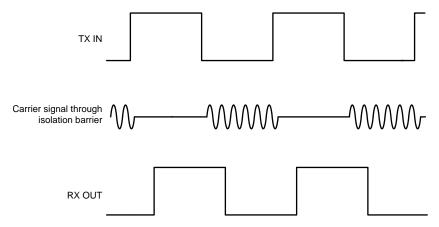


Figure 12. On-Off Keying (OOK) Based Modulation Scheme



8.3 Feature Description

Table 1 lists the device features.

Table 1. Device Features

PART NUMBER	CHANNEL DIRECTION	RATED ISOLATION	MAXIMUM DATA RATE	DEFAULT OUTPUT	
ISO7842	2 Forward,	5700 V _{RMS} / 8000 V _{PK} ⁽¹⁾	100 Mbps	High	
1307642	2 Reverse	5700 VRMS / 6000 VPK V	TOO IVIDPS	підіі	
10070405	2 Forward,	5700 V	100 Mbno	Low	
ISO7842F	2 Reverse	5700 V _{RMS} / 8000 V _{PK} ⁽¹⁾	100 Mbps	Low	

⁽¹⁾ See Regulatory Information for detailed isolation ratings.

8.3.1 High Voltage Feature Description

NOTE

This coupler is suitable for 'safe electrical insulation' only within the safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.

Table 2. Package Insulation and Safety-Related Specifications over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
CLR	External clearance	Shortest terminal-to-terminal distance	16-DW Package	8			
CLK	External clearance	through air	16-DWW Package	14.5			mm
CPG	Futamed annual	Shortest terminal-to-terminal distance	16-DW Package	8			
CPG	External creepage	across the package surface	16-DWW Package	14.5			mm
CTI	Comparative tracking index	DIN EN 60112 (VDE 0303-11); IEC 601	12; UL 746A	600			V
D	Isolation resistance, input to	V _{IO} = 500 V, T _A = 25°C		10 ¹²			Ω
R _{IO}	output ⁽¹⁾	$V_{IO} = 500 \text{ V}, 100^{\circ}\text{C} \le T_{A} \le \text{max}$		10 ¹¹			Ω
C _{IO}	Barrier capacitance, input to output ⁽¹⁾	$V_{IO} = 0.4 \times \sin(2\pi ft)$, f = 1 MHz			2		pF
Cı	Input capacitance (2)	$V_I = V_{CC}/2 + 0.4 \times \sin(2\pi ft)$, $f = 1 \text{ MHz}$,	V _{CC} = 5 V		2		pF

⁽¹⁾ All pins on each side of the barrier tied together creating a two-terminal device.

NOTE

Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed-circuit board do not reduce this distance.

Creepage and clearance on a printed-circuit board become equal in certain cases. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

Product Folder Links: ISO7842 ISO7842F

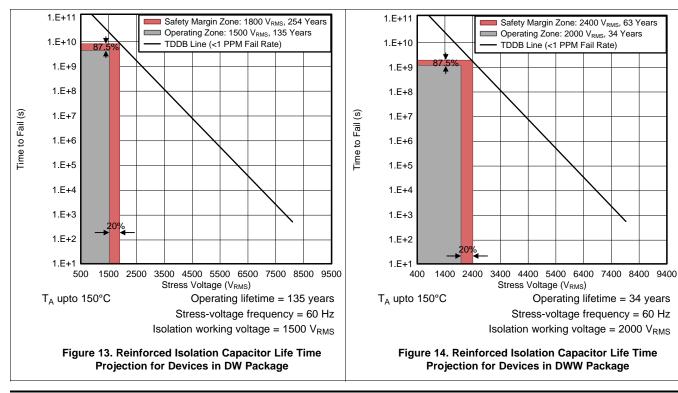
⁽²⁾ Measured from input pin to ground.



Table 3. Insulation Characteristics

		TEST SOURITIONS	SPECIF	ICATION	
	PARAMETER	TEST CONDITIONS	DW	DWW	UNIT
DTI	Distance through the insulation	Minimum internal gap (internal clearance)	>21	>21	μm
V	Maximum rated working isolation	Time dependent dielectric breakdown (TDDB) Test, see	1500	2000	V_{RMS}
V _{IOWM}	voltage	Figure 13 and Figure 14	2121	2828	V_{DC}
DIN V	VDE V 0884-10 (VDE V 0884-10):200	06-12			
V _{IOTM}	Maximum rated transient isolation voltage	V _{TEST} = V _{IOTM} t = 60 sec (qualification) t= 1 sec (100% production)	8000	8000	V _{PK}
V _{IOSM}	Maximum surge isolation voltage for reinforced insulation	Test method per IEC 60065, 1.2/50 μ s waveform, $V_{TEST} = 1.6 \times V_{IOSM} = 12800 \ V_{PK}^{(1)}$ (qualification)	8000	8000	V _{PK}
V_{IORM}	Maximum rated repetitive peak isolation voltage		2121	2828	V_{PK}
		Method a, After Input/Output safety test subgroup 2/3, $V_{PR} = V_{IORM} \times 1.2$, $t = 10 \text{ s}$, Partial discharge < 5 pC	2545	3394	
V _{PR}	Input-to-output test voltage	Method a, After environmental tests subgroup 1, $V_{PR} = V_{IORM} \times 1.6$, $t = 10 \text{ s}$, Partial Discharge $< 5 \text{ pC}$	3394	4525	V _{PK}
		Method b1, V _{PR} = V _{IORM} × 1.875, t = 1 s (100% Production test) Partial discharge < 5 pC	3977	5303	
R _S	Isolation resistance	V_{IO} = 500 V at T_S	>10 ⁹	>10 ⁹	Ω
	Pollution degree		2	2	
	Climatic category		55/125/21	55/125/21	
UL 157	7				
V _{ISO}	Maximum withstanding isolation voltage	$\begin{array}{l} V_{TEST}=V_{ISO}=5700~V_{RMS},~t=60~sec~(qualification),\\ V_{TEST}=1.2~\times~V_{ISO}=6840~V_{RMS},~t=1~sec~(100\%\\ production) \end{array}$	5700	5700	V _{RMS}

(1) Testing is carried out in air or oil to determine the intrinsic surge immunity of the isolation barrier.



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Table 4. IEC 60664-1 Ratings Table

PARAMETER		TEST CONDITIONS	SPECIFICATION
Material group			I
	DW pookege	Rated mains voltage ≤ 600 V _{RMS}	I–IV
Overvoltage category / Installation classification	DW package	Rated mains voltage ≤ 1000 V _{RMS}	I–III
motaliation olassinoation	DWW package	Rated mains voltage ≤ 1000 V _{RMS}	I–IV

8.3.1.1 Regulatory Information

Certifications for the DW package are complete. DWW package certifications are complete for UL, VDE and TUV and planned for CSA and CQC.

Table 5. Regulatory Information

VDE	CSA	UL	CQC	TUV
Certified according to DIN V VDE V 0884-10 (VDE V 0884-10):2006-12 and DIN EN 60950-1 (VDE 0805 Teil 1):2011-01	Approved under CSA Component Acceptance Notice 5A, IEC 60950-1 and IEC 60601-1	Certified according to UL 1577 Component Recognition Program	Certified according to GB 4943.1-2011	Certified according to EN 61010-1:2010 (3rd Ed) and EN 60950-1:2006/A11:2009/A1:2010/ A12:2011/A2:2013
Reinforced insulation Maximum transient isolation voltage, 8000 V _{PK} ; Maximum repetitive peak isolation voltage, 2121 V _{PK} (DW), 2828 V _{PK} (DWW); Maximum surge isolation voltage, 8000 V _{PK}	Reinforced insulation per CSA 60950-1-07+A1+A2 and IEC 60950-1 2nd Ed., 800 V _{RMS} (DW package) and 1450 V _{RMS} (DWW package) max working voltage (pollution degree 2, material group I); 2 MOPP (Means of Patient Protection) per CSA 60601-1:14 and IEC 60601-1 Ed. 3.1, 250 V _{RMS} (354 V _{PK}) max working voltage (DW package)	Single protection, 5700 V _{RMS}	Reinforced Insulation, Altitude ≤ 5000 m, Tropical Climate, 250 V _{RMS} maximum working voltage	5700 V _{RMS} Reinforced insulation per EN 61010-1:2010 (3rd Ed) up to working voltage of 600 V _{RMS} (DW package) and 1000 V _{RMS} (DWW package) 5700 V _{RMS} Reinforced insulation per EN 60950-1:2006/A11:2009/A1:2010/A12:2011/A2:2013 up to working voltage of 800 V _{RMS} (DW package) and 1450 V _{RMS} (DWW package)
Certificate number: 40040142	Master contract number: 220991	File number: E181974	Certificate number: CQC15001121716	Client ID number: 77311

Product Folder Links: ISO7842 ISO7842F



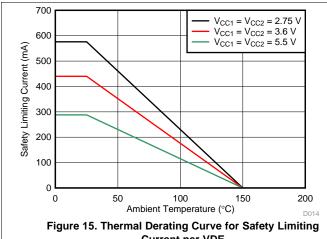
8.3.1.2 Safety Limiting Values

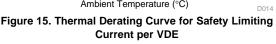
Safety limiting intends to minimize potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the I/O can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier potentially leading to secondary system failures.

Table 6. Safety Limiting Values

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	$R_{\theta JA} = 78.9^{\circ}C/W, V_I = 5.5 V, T_J = 150^{\circ}C, T_A = 25^{\circ}C$			288		
Is	I _S Safety input, output, or supply current	$R_{\theta JA} = 78.9^{\circ}C/W, V_I = 3.6 V, T_J = 150^{\circ}C, T_A = 25^{\circ}C$			440	mA
		$R_{\theta JA} = 78.9^{\circ}C/W, V_I = 2.75 V, T_J = 150^{\circ}C, T_A = 25^{\circ}C$			576	
Ps	Safety input, output, or total power	R _{0JA} = 78.9°C/W, T _J = 150°C, T _A = 25°C			1584	mW
T _S	Maximum safety temperature				150	ô

The maximum safety temperature is the maximum junction temperature specified for the device. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the *Thermal Information* table is that of a device installed on a High-K test board for leaded surface mount packages. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.





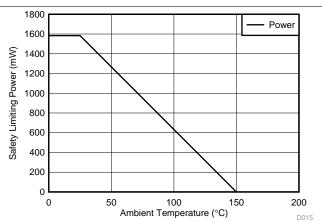


Figure 16. Thermal Derating Curve for Safety Limiting Power per VDE

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8.4 Device Functional Modes

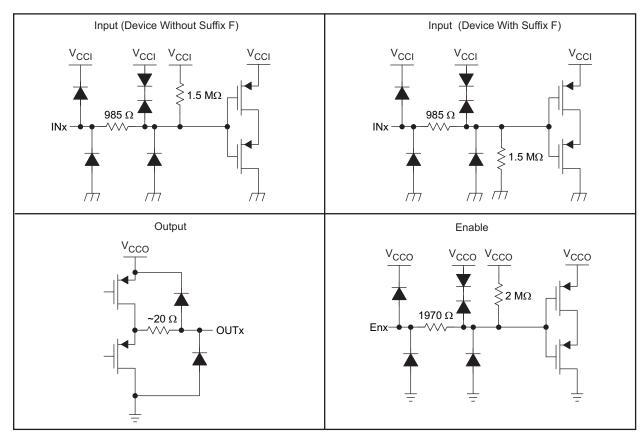
Table 7 lists the ISO7842 functional modes.

Table 7. Function Table (1)

V _{CCI}	V _{cco}	INPUT (INx) ⁽²⁾	OUTPUT ENABLE (ENx)	OUTPUT (OUTx)	COMMENTS
		Н	H or open	Н	Normal Operation:
PU	PU	L	H or open	L	A channel output assumes the logic state of its input.
	. 0	Open	H or open	Default	Default mode: When INx is open, the corresponding channel output goes to its default logic state. Default= High for ISO7842 and Low for ISO7842F.
Х	PU	Х	L	Z	A low value of Output Enable causes the outputs to be high-impedance
PD	PU	Х	H or open	Default	Default mode: When V_{CCl} is unpowered, a channel output assumes the logic state based on the selected default option. Default= High for ISO7842 and Low for ISO7842F. When V_{CCl} transitions from unpowered to powered-up, a channel output assumes the logic state of its input. When V_{CCl} transitions from powered-up to unpowered, channel output assumes the selected default state.
Х	PD	Х	х	Undetermined	When V_{CCO} is unpowered, a channel output is undetermined ⁽³⁾ . When V_{CCO} transitions from unpowered to powered-up, a channel output assumes the logic state of its input

- V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC} ; PU = Powered up ($V_{CC} \ge 2.25$ V); PD = Powered down ($V_{CC} \le 1.7$ V); X = Irrelevant; H = High level; L = Low level ; Z = High Impedance
- A strongly driven input signal can weakly power the floating V_{CC} through an internal protection diode and cause undetermined output. The outputs are in undetermined state when 1.7 V < V_{CCI} , V_{CCO} < 2.25 V.

8.4.1 Device I/O Schematics



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Figure 17. Device I/O Schematics



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The ISO7842 device is a high-performance, quad-channel digital isolator with a 5.7-kV_{RMS} isolation voltage per UL 1577. The device comes with enable pins on each side that can be used to put the respective outputs in high impedance for multi-master driving applications and reduce power consumption. The ISO7842 device uses single-ended CMOS-logic switching technology. The supply voltage range is from 2.25 V to 5.5 V for both supplies, V_{CC1} and V_{CC2} . When designing with digital isolators, keep in mind that because of the single-ended design structure, digital isolators do not conform to any specific interface standard and are only intended for isolating single-ended CMOS or TTL digital signal lines. The isolator is typically placed between the data controller (that is, μ C or UART), and a data converter or a line transceiver, regardless of the interface type or standard.

9.2 Typical Application

Figure 18 shows the typical isolated RS-232 interface implementation.

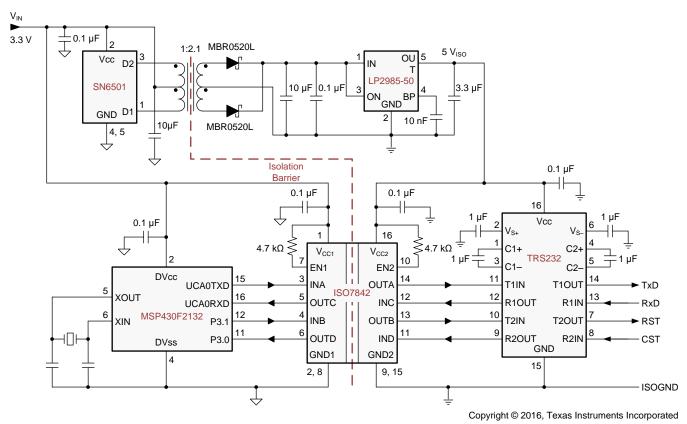


Figure 18. Isolated RS-232 Interface



Typical Application (continued)

9.2.1 Design Requirements

For this design example, use the parameters shown in Table 8.

Table 8. Design Parameters

PARAMETER	VALUE
Supply voltage	2.25 to 5.5 V
Decoupling capacitor between V _{CC1} and GND1	0.1 μF
Decoupling capacitor from V _{CC2} and GND2	0.1 μF

9.2.2 Detailed Design Procedure

Unlike optocouplers, which require external components to improve performance, provide bias, or limit current, the ISO7842 device only requires two external bypass capacitors to operate.

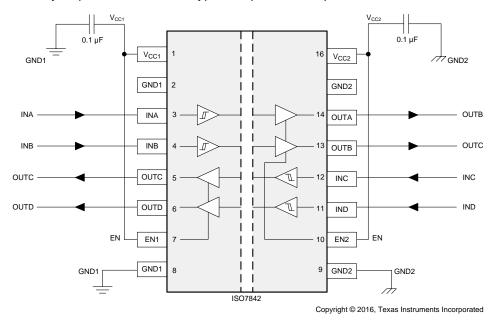


Figure 19. Typical ISO7842 Circuit Hook-Up

9.2.2.1 Electromagnetic Compatibility (EMC) Considerations

Many applications in harsh industrial environment are sensitive to disturbances such as electrostatic discharge (ESD), electrical fast transient (EFT), surge, and electromagnetic emissions. These electromagnetic disturbances are regulated by international standards such as IEC 61000-4-x and CISPR 22. Although system-level performance and reliability depends, to a large extent, on the application board design and layout, the ISO7842 device incorporates many chip-level design improvements for overall system robustness. Some of these improvements include

- Robust ESD protection cells for input and output signal pins and inter-chip bond pads.
- Low-resistance connectivity of ESD cells to supply and ground pins.
- Enhanced performance of high voltage isolation capacitor for better tolerance of ESD, EFT and surge events.
- Bigger on-chip decoupling capacitors to bypass undesirable high energy signals through a low impedance path.
- PMOS and NMOS devices isolated from each other by using guard rings to avoid triggering of parasitic SCRs.
- Reduced common mode currents across the isolation barrier by ensuring purely differential internal operation.

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9.2.3 Application Curve

The typical eye diagram of the ISO7842 device indicates low jitter and wide open eye at the maximum data rate of 100 Mbps.

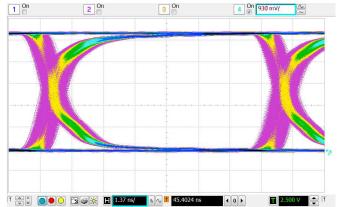


Figure 20. Eye Diagram at 100 Mbps PRBS, 5 V and 25°C

10 Power Supply Recommendations

To help ensure reliable operation at data rates and supply voltages, a 0.1- μ F bypass capacitor is recommended at input and output supply pins (V_{CC1} and V_{CC2}). The capacitors should be placed as close to the supply pins as possible. If only a single primary-side power supply is available in an application, isolated power can be generated for the secondary-side with the help of a transformer driver such as Texas InstrumentsSN6501. For such applications, detailed power supply design and transformer selection recommendations are available in the SN6501 data sheet (SLLSEA0).



11 Layout

11.1 Layout Guidelines

A minimum of four layers is required to accomplish a low EMI PCB design (see Figure 21). Layer stacking should be in the following order (top-to-bottom): high-speed signal layer, ground plane, power plane and low-frequency signal layer.

- Routing the high-speed traces on the top layer avoids the use of vias (and the introduction of their inductances) and allows for clean interconnects between the isolator and the transmitter and receiver circuits of the data link.
- Placing a solid ground plane next to the high-speed signal layer establishes controlled impedance for transmission line interconnects and provides an excellent low-inductance path for the return current flow.
- Placing the power plane next to the ground plane creates additional high-frequency bypass capacitance of approximately 100 pF/inch².
- Routing the slower speed control signals on the bottom layer allows for greater flexibility as these signal links
 usually have margin to tolerate discontinuities such as vias.

If an additional supply voltage plane or signal layer is needed, add a second power or ground plane system to the stack to keep it symmetrical. This makes the stack mechanically stable and prevents it from warping. Also the power and ground plane of each power system can be placed closer together, thus increasing the high-frequency bypass capacitance significantly.

For detailed layout recommendations, see the application note, Digital Isolator Design Guide (SLLA284).

11.1.1 PCB Material

For digital circuit boards operating at less than 150 Mbps, (or rise and fall times greater than 1 ns), and trace lengths of up to 10 inches, use standard FR-4 UL94V-0 printed circuit board. This PCB is preferred over cheaper alternatives because of lower dielectric losses at high frequencies, less moisture absorption, greater strength and stiffness, and the self-extinguishing flammability-characteristics.

11.2 Layout Example

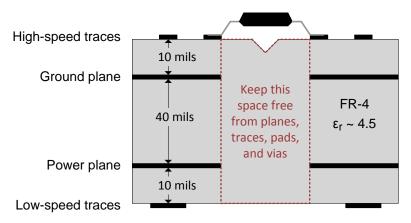


Figure 21. Layout Example Schematic



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation, see the following:

- Digital Isolator Design Guide, SLLA284
- Isolation Glossary , SLLA353
- LP2985 150-mA Low-noise Low-dropout Regulator With Shutdown, SLVS522
- MSP430G2x32, MSP430G2x02 Mixed Signal Microcontroller, SLAS723
- SN6501 Transformer Driver for Isolated Power Supplies, SLLSEA0
- TRS232 Dual RS-232 Driver/Receiver With IEC61000-4-2 Protection, SLLS861

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 9. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
ISO7842	Click here	Click here	Click here	Click here	Click here	
ISO7842F	Click here	Click here	Click here	Click here	Click here	

12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: ISO7842 ISO7842F



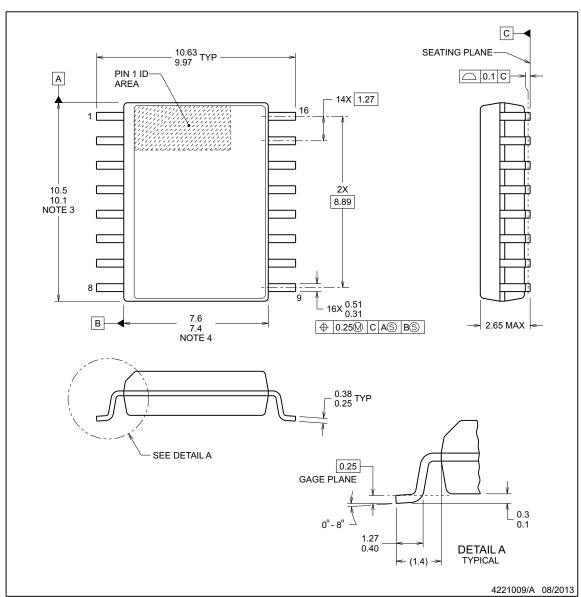
DW0016B



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

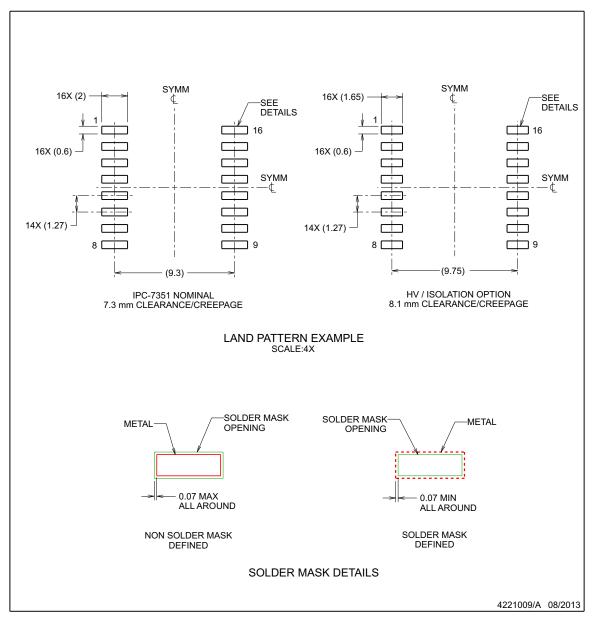
- All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MO-013, variation AA.



EXAMPLE BOARD LAYOUT

DW0016B

SOIC - 2.65 mm max height



NOTES: (continued)

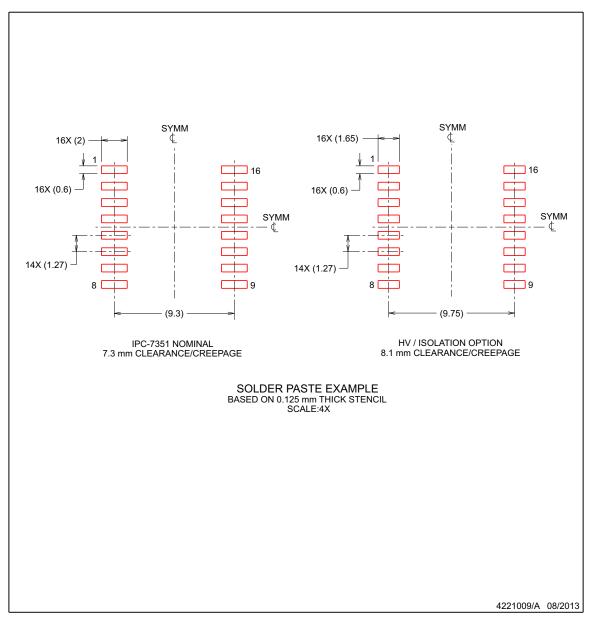
6. Publication IPC-7351 may have alternate designs.7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



EXAMPLE STENCIL DESIGN

DW0016B

SOIC - 2.65 mm max height



NOTES: (continued)

^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



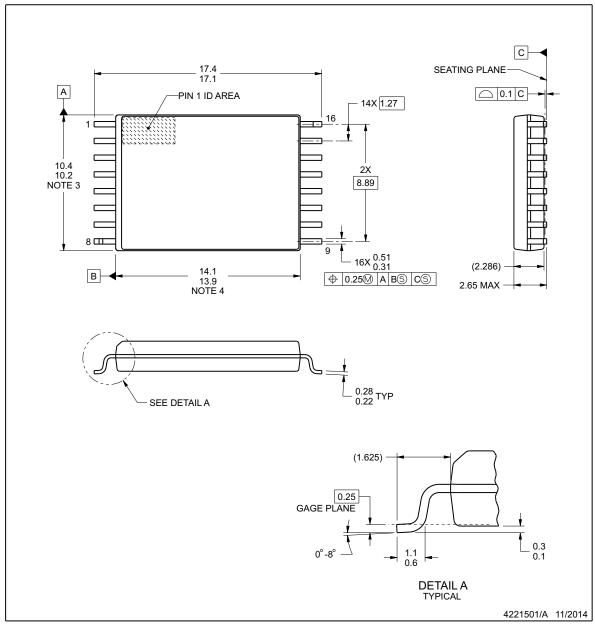
DWW0016A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

PLASTIC SMALL OUTLINE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 mm per side.
- 4. This dimension does not include interlead flash.

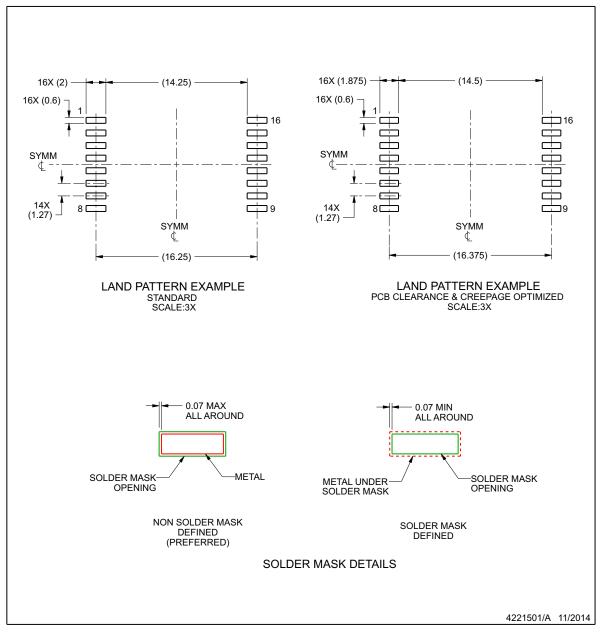


EXAMPLE BOARD LAYOUT

DWW0016A

SOIC - 2.65 mm max height

PLASTIC SMALL OUTLINE



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

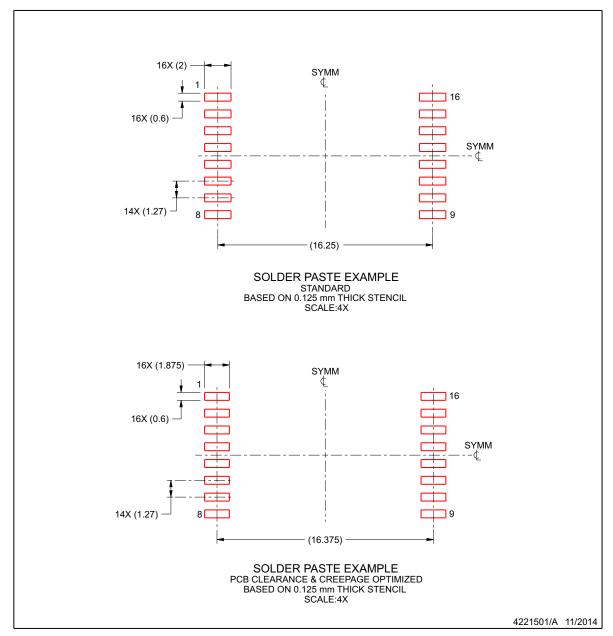


EXAMPLE STENCIL DESIGN

DWW0016A

SOIC - 2.65 mm max height

PLASTIC SMALL OUTLINE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.





19-Jun-2016

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
ISO7842DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842	Samples
ISO7842DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842	Samples
ISO7842DWW	ACTIVE	SOIC	DWW	16	45	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842	Samples
ISO7842DWWR	ACTIVE	SOIC	DWW	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842	Samples
ISO7842FDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842F	Samples
ISO7842FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842F	Samples
ISO7842FDWW	ACTIVE	SOIC	DWW	16	45	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842F	Samples
ISO7842FDWWR	ACTIVE	SOIC	DWW	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7842F	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



PACKAGE OPTION ADDENDUM

19-Jun-2016

- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

All differsions are norminal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7842DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7842DWWR	SOIC	DWW	16	1000	330.0	24.4	18.0	10.0	3.0	20.0	24.0	Q1
ISO7842FDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7842FDWWR	SOIC	DWW	16	1000	330.0	24.4	18.0	10.0	3.0	20.0	24.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7842DWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7842DWWR	SOIC	DWW	16	1000	367.0	367.0	45.0
ISO7842FDWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7842FDWWR	SOIC	DWW	16	1000	367.0	367.0	45.0

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